

Issue Classification

Application/Control No.

10730672

Applicant(s)/Patent Under Reexamination

YOSHIYAMA ET AL.

Examiner

Bae, Ji H

Art Unit

2115

ORIGINAL

CLASS

SUBCLASS

713

320

CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

713

300

INTERNATIONAL CLASSIFICATION

CLAIMED

NON-CLAIMED

G 0 6 F

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1 / 00 (2006.01.01)

Bae, Ji H

(Assistant Examiner)

5-10-2007

(Date)

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Total Claims Allowed:

9

(Legal Instruments
Examiner)

(Date)

O.G. Print Claim(s)

1

O.G. Print Figure

1